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B. Kolaric* and R. A. L. Vallée: Dynamics and Stability of DNA Mechano-Nanostructures: Energy-Transfer Investigations

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M. Yashima* and T. Takizawa: Atomic Displacement Parameters of Ceria Doped with Rare-Earth Oxide $Ce_{0.8}R_{0.2}O_{1.9}$ (R = La, Nd, Sm, Gd, Y, and Yb) and Correlation with Oxide-Ion Conductivity

Page 2385. Corrected Table 1 is shown below (corrections in bold). The corrections do not affect on the description, figures and conclusions.

TABLE 1: Refined Crystallographic Parameters and Reliability Factors in the Rietveld Analysis of Synchrotron X-ray Powder Diffraction Data of $Ce_{0.8}R_{0.2}O_{1.9}$ (R = La, Nd, Sm, Gd, Y, and Yb)

T/°C			Yb	Y	Gd	Sm	Nd	La
29.5	4*a*	U_C/Å^2	0.01014(13)	0.0097(10)	0.0089(3)	0.0098(2)	0.0100(11)	0.0096(2)
	8*c*	U_O/Å^2	0.0178(6)	0.0174(11)	0.0156(5)	0.0187(5)	0.0202(13)	0.0226(6)
	a/Å[a]		5.39106(3)	**5.40593(3)**	5.42573(1)	5.43688(3)	5.44482(3)	5.47630(2)
	R_{wp}/%[b]		7.23	**5.44**	5.51	6.21	7.26	7.00
	R_1/%[b]		1.51	**2.29**	4.69	3.79	2.63	3.15
	R_F/%[b]		2.04	**3.34**	5.59	5.81	2.99	5.44
	S[c]		1.26	**1.14**	1.09	0.96	1.52	1.36
408.0	4*a*	U_C/Å^2	0.0147(7)	0.0144(15)	0.0132(2)	0.0128(4)	0.0140(10)	0.0142(4)
	8*c*	U_O/Å^2	0.0272(10)	0.0273(15)	0.0237(6)	0.0254(7)	0.0297(12)	0.0317(7)
	a/Å[a]		5.41364(3)	5.42964(2)	5.45096(2)	5.45912(3)	5.46798(3)	5.50126(2)
	R_{wp}/%[b]		6.84	4.47	5.64	6.27	5.79	6.32
	R_1/%[b]		2.26	2.86	4.85	3.26	1.92	3.55
	R_F/%[b]		3.71	5.43	7.62	6.08	2.77	7.60
	S[c]		1.14	0.89	1.12	0.96	1.21	1.25
675.0	4*a*	U_C/Å^2	0.0177(6)	0.0168(10)	0.0160(2)	0.0162(3)	0.0167(6)	0.0176(3)
	8*c*	U_O/Å^2	0.0333(9)	0.0329(11)	**0.0307(7)**	0.0329(8)	0.0351(9)	0.0390(8)
	a/Å[a]		5.43339(3)	5.44847(5)	**5.46934(2)**	5.47721(2)	5.48593(2)	5.51989(2)
	R_{wp}/%[b]		5.50	3.77	**6.01**	6.50	5.02	5.89
	R_1/%[b]		2.27	2.91	**5.06**	3.82	2.46	3.32
	R_F/%[b]		3.12	4.58	**8.57**	7.98	3.10	8.17
	S[c]		0.93	0.76	**1.21**	1.01	1.06	1.19

[a] Unit-cell parameter. [b] Reliability factors in the Rietveld analysis. [c] Goodness of fit in the Rietveld analysis. See Table S1 for the occupancy factors used in the analyses.

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